

Notice of References Cited	Application/Control No. 09/942,615		Applicant(s)/Patent Under Reexamination KIMURA ET AL.	
	Examiner Kristie Shingles		Art Unit 2141	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,594,699	07-2003	Sahai et al.	709/228
*	B	US-6,553,100	04-2003	Chen et al.	379/37
*	C	US-2002/0028024	03-2002	Jayant et al.	382/243
*	D	US-5,774,857	06-1998	Newlin, Douglas J.	704/271
*	E	US-6,029,194	02-2000	Tilt, Christopher E.	725/94
*	F	US-2001/0016869	08-2001	Baumeister et al.	709/203
*	G	US-6,697,566	02-2004	Fujinami et al.	386/111
*	H	US-5,392,165	02-1995	Hosono et al.	386/92
*	I	US-6,072,832	06-2000	Katto, Jiro	375/240.28
*	J	US-2002/0013820	01-2002	Crandall, Evan Stephen	709/208
*	K	US-6,427,150	07-2002	Oashi et al.	707/10
*	L	US-6,327,616	12-2001	Ohto et al.	709/219
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.